Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/829,583	CHEN ET AL.
Examiner	Art Unit

2826

Leonardo Andújar

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Search updated	8/31/2006	LA	
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